1/16/08	Application Number		10597811
INFORMATION DIGGLOCULE	Filing Date		2007-04-13
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Not for submission under 37 CFR 1.99)	First Named Inventor	Sparta	ak Gevorgian
	Art Unit		2821
	Examiner Name	U nas	eigned CTRAN
	Attorney Docket Numb	er	0110-096
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/C.T./	3	0247206	wo	A1	2002-06-13	Bergstedt et al.				
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